Applicant(s)/Patent Under Reexamination Application/Control No. 09/509,108 MAIER ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 2653

Kim-Kwok CHU

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,283,764	09-2001	Kajiyama et al.	434/307A
	В	US-5,889,745	03-1999	Aramaki, Junichi	369/53.34
	С	US-5,822,283	10-1998	Bos et al.	369/30.28
	D	US-5,768,252	06-1998	Yokota, Teppei	369/30.04
	Е	US-5,683,253	11-1997	Park et al.	434/307A
	F	US-5,570,340	10-1996	Lee et al.	369/47.31
	G	US-5,574,239	11-1996	Kang et al.	84/610
	Н	US-5,337,296	08-1994	Okubo, Hirotoshi	369/30.1
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	,				
	0					•
	Р					
	a			-		
	R				·	
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	w				
	x				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.